

**Notice of References Cited**

Application/Control No.

10/531,349

Applicant(s)/Patent Under

Reexamination

PACHUK ET AL.

Examiner

Richard Schnizer, Ph. D.

Art Unit

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**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2004/0053876	03-2004	Turner et al.	514/044
B	US-			
C	US-			
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
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**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Masson et al (Proc. Nat. Acad. Sci. USA 84: 6815-6819, 1987)
V	
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